

Seiko Epson NX1032XS IC Test Handlers (JAD-39367)

Make: Epson

Model: NX1032XS

Manufactuers Spec: https://www.epson.com.ph/For-Work/IC-Handler/IC-

Handler/Epson-NX1032XS-IC-Test-Handler/p/NX1032XS

Qty: 10 Inspection: Yes

Devices Handled:

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16-site | 32-site QFP, TSOP, CSP, WLCSP, BGA, QFN, PLCC, LGA, PGA, Min. 3x3 to Max. 50x50 (Lead pitch: 0.4mm or more) *1

Test Mode:

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N/A | 32-site (8×4, X: 40mm pitch × Y: 60mm pitch)

16-site (8×2, X: 30mm pitch Y: 60mm pitch, 40mm

pitch x Y: 60mm pitch)
8-site (4x2, X: 40mm pitch x Y: 60mm, X: 60mm
pitch x Y: 60mm, X: 80mm pitch x Y: 60mm)
4-site (2x2, X: 80mm x Y: 60mm), (4x1, X: 40mm,

60mm, 80mm)

2-site (Socket pitch 80 mm)
Single (use one side of the 2-site test)

Non-standard pitches can be set by laying out the independent compliance unit with desired pitches

Testing Area:

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344 × 146 mm | 344 × 244 mm

